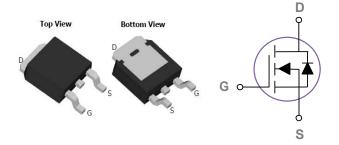


General Description

The KSD90N10 ries are from Advanced Power innovated design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

TO-252 Pin Configuration



Product Summary

V _{DS} (V)	$R_{DS(on)}$ (m Ω)	I _D (A)
100	5 at VGS = 10 V	90
	6 at VGS = 4.5 V	75

Features

- Special process technology for high ESD capability
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation

Applications

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	100	V
V _G s	Gate-Source Voltage	±20	V
	Drain Current – Continuous (T _C =25°C)	90	А
lo	Drain Current – Continuous (Tc=100°C)	60	А
I _{DM}	Drain Current – Pulsed¹	270	А
D-	Power Dissipation (Tc=25°C)	85	W
P _D	Power Dissipation (Tc=100℃)	1.4	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	℃
TJ	Operating Junction Temperature Range	-55 to 150	℃

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient		58	°C/W
Rejc	Thermal Resistance Junction to Case		4.3	°C/W



Electrical Characteristics (T_J=25 ℃, unless otherwise noted) Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	100			V
IDSS	Drain-Source Leakage Current	V_{DS} =80V , V_{GS} =0V , T_{J} =25°C			20	uA
		V _{DS} =80V , V _{GS} =0V , T _J =125℃			10	uA
Igss	Gate-Source Leakage Current	V_{GS} = $\pm 20 V$, V_{DS} = $0 V$			±100	nA

On Characteristics

R _{DS(ON)} Static Drain-Source On-Resistance	Statio Drain Source On Registance	V_{GS} =10V , I_D =20A		5	6.3	mΩ
	V _{GS} =4.5V , I _D =10A		6.0	7.8	mΩ	
$V_{GS(th)}$	Gate Threshold Voltage	-V _{GS} =V _{DS} , I _D =250uA	1.0	1.8	3.0	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			3		mV/℃
gfs	Forward Transconductance	V _{DS} =10V , I _S =10A		30		S

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{2, 3}		 89	
Q_{gs}	Gate-Source Charge ^{2,3}	V_{DS} =50V , V_{GS} =10V , I_{D} =20A	 11	 nC
Q_gd	Gate-Drain Charge ^{2, 3}		 14.6	
$T_{d(on)}$	Turn-On Delay Time ^{2, 3}		 13.4	
Tr	Rise Time ^{2, 3}	Vps=50V, Ip=20A	 45	 ns
$T_{d(off)}$	Turn-Off Delay Time ^{2, 3}	V _G s=10V,R _G =2.5Ω	 37	 115
T_f	Fall Time ^{2, 3}		 60	
C _{iss}	Input Capacitance		 3950	
Coss	Output Capacitance	V _{DS} =50V , V _{GS} =0V , F=1MHz	 1568	 pF
Crss	Reverse Transfer Capacitance		 204	

Drain-Source Diode Characteristics and Maximum Ratings

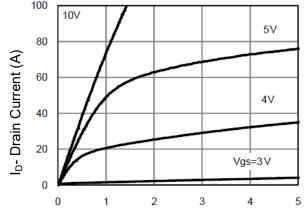
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	V _G =V _D =0V , Force Current			90	Α
I _{SM}	Pulsed Source Current				160	Α
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =1A , T _J =25℃			1.2	V

Note:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- **3.** Pulse Test: Pulse Width ≤ 300μ s, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production
- **5.** EAS condition: Tj=25 $^{\circ}$ C,VDD=50V,VG=10V,L=0.5mH,Rg=25 Ω

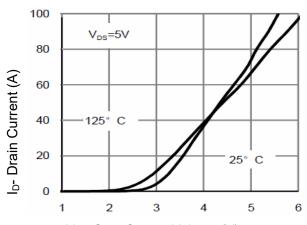




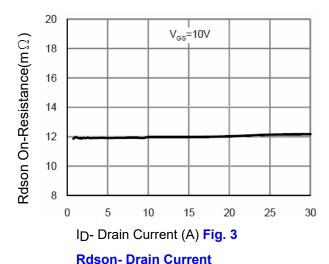


Vds Drain-Source Voltage (V)





Vgs Gate-Source Voltage (V)
Fig. 2 Transfer Characteristics



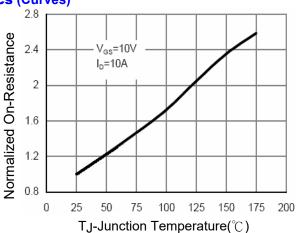


Fig. 4 Rdson-JunctionTemperature

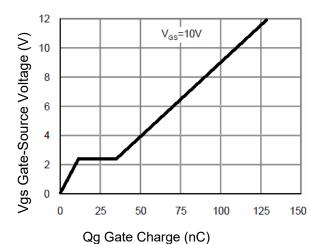
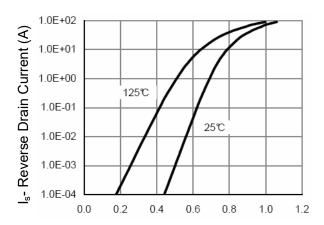


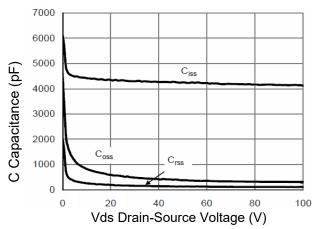
Fig. 5 Gate Charge



Vsd Source-Drain Voltage (V)

Fig. 6 Source- Drain Diode Forward





Figu.7 Capacitance vs Vds

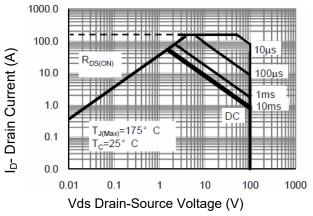


Fig.9 Safe Operation Area

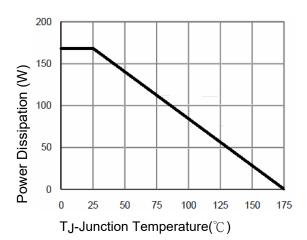


Fig. 8 Power De-rating

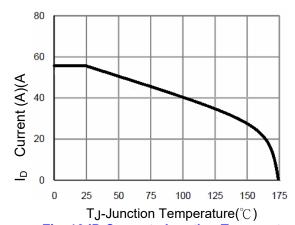


Fig. 10 ID Current- Junction Temperature

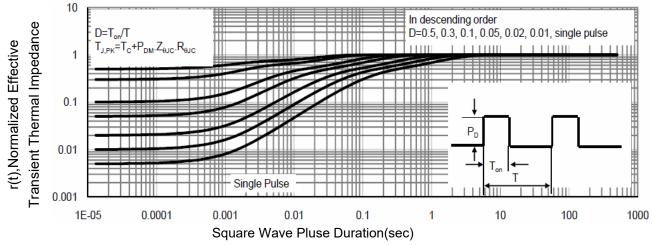


Fig.11 Normalized Maximum Transient Thermal Impedance



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